





LIST OF PUBLICATIONS  
CITED BY APPLICANT

Atty Docket No.  
SEL 259

Serial No.  
09/852,220

Applicant  
Shunpei YAMAZAKI  
et al

Filing Date  
May 9, 2001

Group  
2677

US PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
↑ ↓ ↓ ↓	6,524,877 B1	02/25/03	Nakazawa et al	438	48	10/25/00
	6,525,719 B2	02/25/03	Yamazaki et al	345	211	09/06/01
	6,608,613 B2	08/19/03	Koyama et al	345	98	10/29/01
	US 2003/ 0214006 A1	11/20/03	Nakamura et al	257	448	05/07/03
	6,690,033 B2	02/10/04	Yamazaki et al	257	72	02/21/01
	6,703,671 B1	03/09/04	Yamazaki et al	257	404	07/28/99
	US 2005/ 0001541 A1	01/06/05	Yamazaki et al	313	503	08/02/04
	6,858,878 B2	02/22/05	Yamazaki et al	257	98	01/07/03

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	APPLICANT	English Abstract	English Trans.	FILING DATE

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

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**FOREIGN PATENT DOCUMENTS**

	DOCUMENT NUMBER	DATE	APPLICANT	English Abstract	English Trans.	FILING DATE
	JP 06-148685	05/27/94	Toshiba Corp.		X	11/13/92
	JP 06-281957	10/07/94	Toshiba Corp.		X	03/29/93
	JP 07-235680	09/05/95	Toshiba Corp.		X	02/24/94
	JP 08-274336	10/18/96	Toshiba Corp.		X	03/30/95
	JP 10-048640	02/20/98	Toshiba Corp.	X		07/30/96
	EP 1 128 430	08/29/01	Semiconductor			02/22/01
	A2 JP 2001- 313397	11/09/01	Energy Lab Co. Ltd Semiconductor Energy Lab Co. Ltd	X		02/22/01

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